## Notice of References Cited Application/Control No. Applicant(s)/Patent Under Reexamination CHANG ET AL. Examiner Daborah Chacko-Davis Applicant(s)/Patent Under Reexamination CHANG ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,282,066	01-1994	Yu et al.	359/3
	В	US-			
	C	US-			
	۵	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			-
	1	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

	HON-I ATEN BOOMENS					
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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